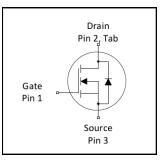
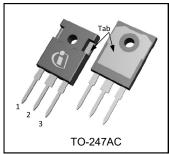


V _{DSS}	60V
R _{DS(on)} typ.	1.65m Ω
max	2.00 m Ω
D (Silicon Limited)	281A①
I _{D (Package Limited)}	195A

Application

- Brushed Motor drive applications
- BLDC Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters





G	D	S
Gate	Drain	Source

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free, RoHS Compliant

Dana mant mumban	Daalaasa Tosa	Standard Pack		Onderskie Deut Neusken
Base part number	Package Type	Form	Quantity	Orderable Part Number
IRFP7530PbF	TO-247AC	Tube	25	IRFP7530PbF

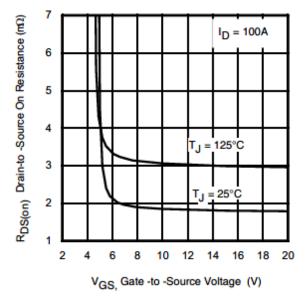


Fig 1. Typical On-Resistance vs. Gate Voltage

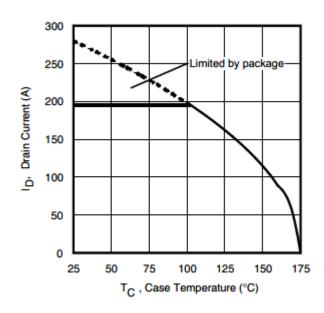


Fig 2. Maximum Drain Current vs. Case Temperature



Absolute Maximum Rating

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	281①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	199①	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Wire Bond Limited)	195	A
ДМ	Pulsed Drain Current ②	760]
P _D @T _C = 25°C	Maximum Power Dissipation	341	W
	Linear Derating Factor	2.3	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
Γ _J Γ _{STG}	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 Screw	10 lbf·in (1.1 N·m)	

Avalanche Characteristics

E _{AS} (Thermally limited)	Single Pulse Avalanche Energy ③	557	m l
E _{AS (Thermally limited)}	Single Pulse Avalanche Energy	1102	mJ
I _{AR}	Avalanche Current ②	See Fig 15, 16, 23a, 23b	Α
E _{AR}	Repetitive Avalanche Energy ②	See Fig. 15, 16, 23a, 23b	mJ

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.44	
$R_{ heta CS}$	Case-to-Sink, Flat Greased Surface	0.24		°C/W
$R_{ heta JA}$	Junction-to-Ambient		40	

Static @ T_J = 25°C (unless otherwise specified)

otatio & ij	20 6 (amood office mod opcomod)					
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		47		mV/°C	Reference to 25°C, I _D = 1mA ②
R _{DS(on)}	Static Drain-to-Source On-Resistance		1.65	2.00	mO	$V_{GS} = 10V, I_D = 100A$
			2.10		mΩ	$V_{GS} = 6.0V, I_D = 50A$
$V_{GS(th)}$	Gate Threshold Voltage	2.1		3.7	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
I	Drain to Source Leakage Current			1.0		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{V}$
I _{DSS}	Drain-to-Source Leakage Current			150	μA	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
IGSS	Gate-to-Source Reverse Leakage			-100	IIA	$V_{GS} = -20V$
R_G	Gate Resistance		2.1		Ω	

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A by source bonding technology. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $\ \ \, \ \,$ Limited by $T_{Jmax},$ starting T_{J} = 25°C, L = 111µH, R_{G} = 50 $\Omega,$ I_{AS} = 100A, V_{GS} =10V.
- ⑤ Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- © C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- ® R_θ is measured at T_J approximately 90°C.
- 9 Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 1mH, $R_G = 50\Omega$, $I_{AS} = 47A$, $V_{GS} = 10V$.



Dynamic Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	242			S	V _{DS} = 10V, I _D =100A
Q_g	Total Gate Charge		274	411		I _D = 100A
Q_{gs}	Gate-to-Source Charge		64		nC	V _{DS} = 30V
Q_{gd}	Gate-to-Drain Charge		83		IIC	V _{GS} = 10V
Q _{sync}	Total Gate Charge Sync. (Qg- Qgd)		191			
$t_{d(on)}$	Turn-On Delay Time		52			$V_{DD} = 30V$
t _r	Rise Time		141			I _D = 100A
$t_{d(off)}$	Turn-Off Delay Time		172		ns	$R_G = 2.7\Omega$
t _f	Fall Time		104			V _{GS} = 10V⑤
C _{iss}	Input Capacitance		13703			V _{GS} = 0V
Coss	Output Capacitance		1266			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		806		pF	f = 1.0MHz, See Fig.7
C _{oss eff.(ER)}	Effective Output Capacitance (Energy Related)		1267		ָרְיאָ 	V _{GS} = 0V, VDS = 0V to 48V⑦
Coss eff.(TR)	Output Capacitance (Time Related)		1630			V _{GS} = 0V, VDS = 0V to 48V [©]

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			281①	1	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ②			760		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C, I_S = 100A, V_{GS} = 0V$ §
dv/dt	Peak Diode Recovery dv/dt⊕		8.1		V/ns	$T_J = 175^{\circ}C, I_S = 100A, V_{DS} = 60V$
t _{rr}	Reverse Recovery Time		51 54		ns	$T_{J} = 25^{\circ}C$ $V_{DD} = 51V$ $T_{J} = 125^{\circ}C$ $I_{F} = 100A$,
Q _{rr}	Reverse Recovery Charge		86 102		nC	<u>T_J = 25°C</u> di/dt = 100A/μs ⑤ <u>T_J = 125°C</u>
I _{RRM}	Reverse Recovery Current		2.9		Α	T _J = 25°C



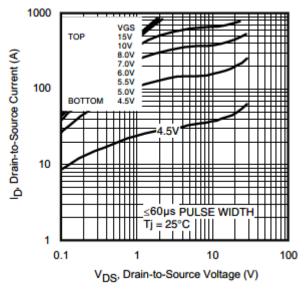


Fig 3. Typical Output Characteristics

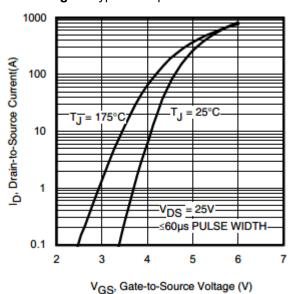


Fig 5. Typical Transfer Characteristics

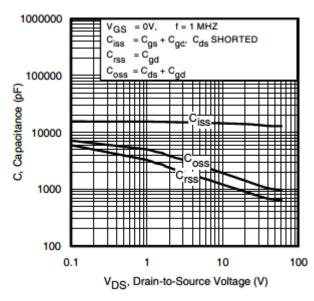


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

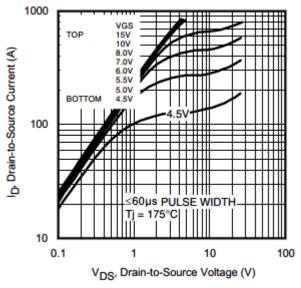


Fig 4. Typical Output Characteristics

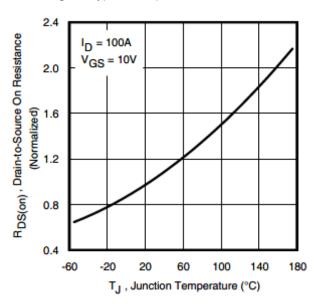


Fig 6. Normalized On-Resistance vs. Temperature

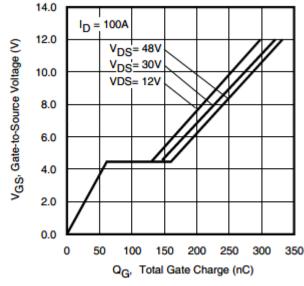


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage



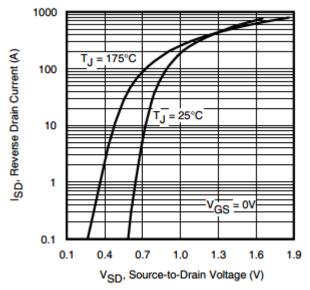


Fig 9. Typical Source-Drain Diode Forward Voltage

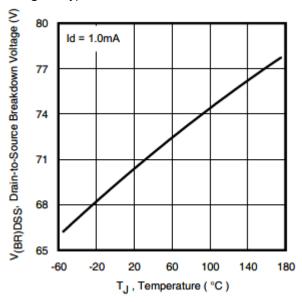


Fig 11. Drain-to-Source Breakdown Voltage

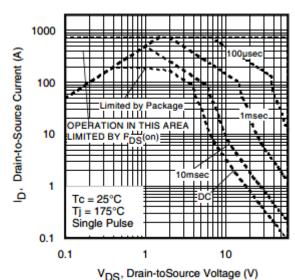


Fig 10. Maximum Safe Operating Area

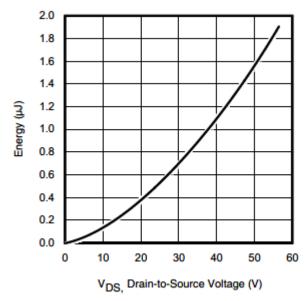


Fig 12. Typical Coss Stored Energy

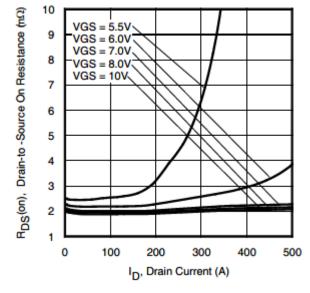


Fig 13. Typical On-Resistance vs. Drain Current



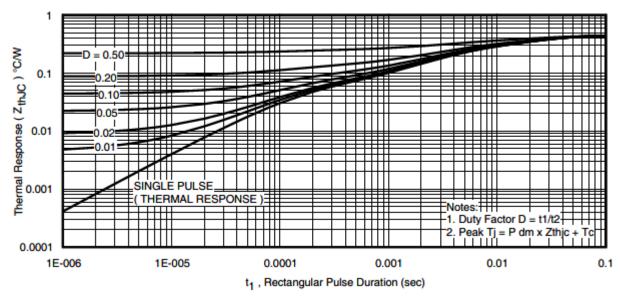


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

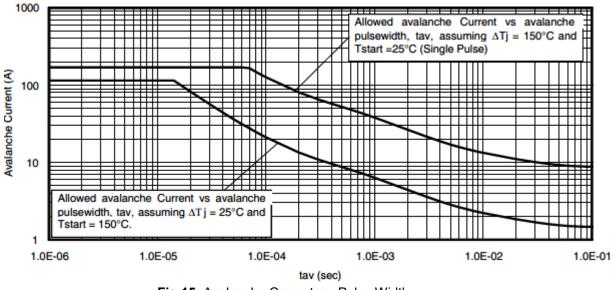


Fig 15. Avalanche Current vs. Pulse Width

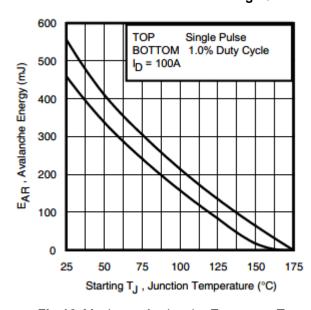


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every

- 2. Safe operation in Avalanche is allowed as long as T_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{imax} (assumed as 25°C in Figure 15, 16). t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 14)

PD (ave) = 1/2 ($1.3 \cdot BV \cdot I_{av}$) = $\Delta T/Z_{thJC}$

 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$

 $E_{AS (AR)} = P_{D (ave)} t_{av}$



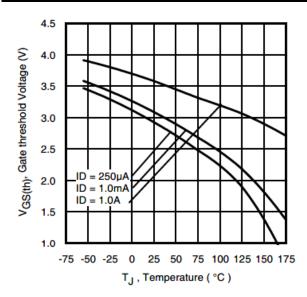


Fig 17. Threshold Voltage vs. Temperature

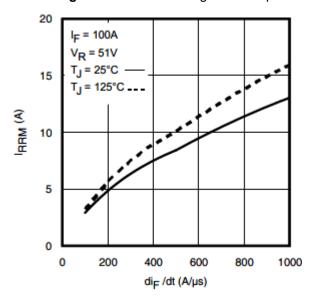


Fig 19. Typical Recovery Current vs. dif/dt

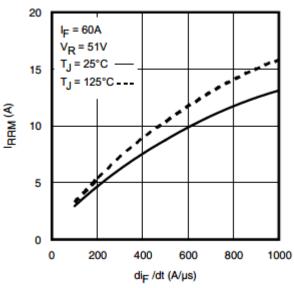


Fig 18. Typical Recovery Current vs. dif/dt

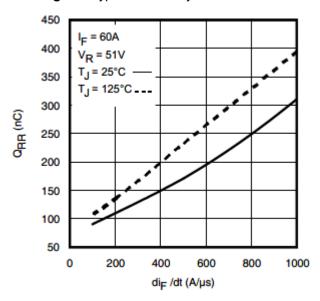


Fig 20. Typical Stored Charge vs. dif/dt

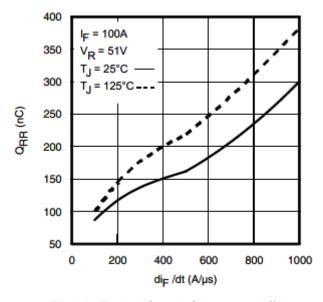


Fig 21. Typical Stored Charge vs. dif/dt



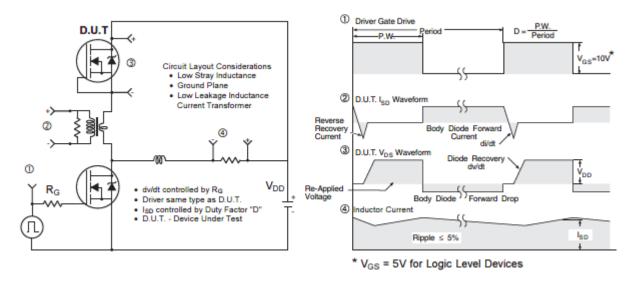


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

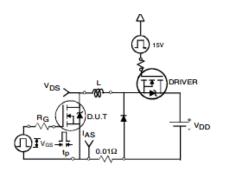


Fig 23a. Unclamped Inductive Test Circuit

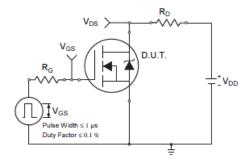


Fig 24a. Switching Time Test Circuit

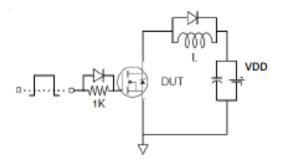


Fig 25a. Gate Charge Test Circuit

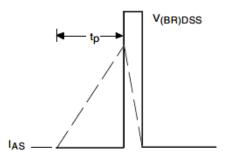


Fig 23b. Unclamped Inductive Waveforms

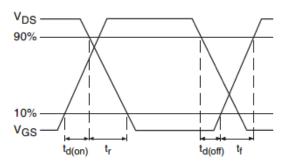


Fig 24b. Switching Time Waveforms

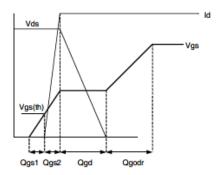
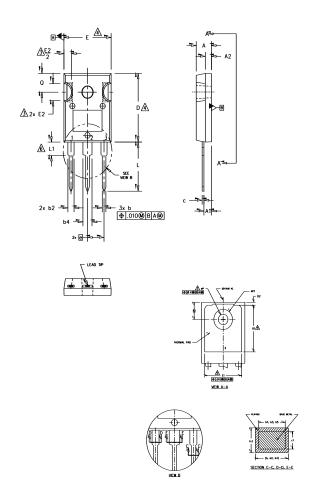


Fig 25b. Gate Charge Waveform



TO-247AC Package Outline (Dimensions are shown in millimeters (inches))



NOTES:

DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994. 1.

DIMENSIONS ARE SHOWN IN INCHES.

CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

OP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 * TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC.

SYMBOL	INCI	HES	MILLIM	ETERS	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
b1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.133	2.59	3.38	
С	.015	.035	0.38	0.89	
c1	.015	.033	0.38	0.84	
D	.776	.815	19.71	20.70	4
D1	.515	-	13.08	-	5
D2	.020	.053	0.51	1.35	
Ε	.602	.625	15.29	15.87	4
E1	.530	-	13.46	-	
E2	.178	.216	4.52	5.49	
е	.215	BSC	5.46	BSC	
Øk	.0	10	0.	25	İ
L	.559	.634	14.20	16.10	İ
L1	.146	.169	3.71	4.29	
øР	.140	.144	3.56	3.66	
øP1	-	.291	-	7.39	
0	.209	.224	5.31	5.69	
S	.217	BSC	5.51	BSC	
					I

LEAD ASSIGNMENTS

<u>HEXFET</u>

- 1 GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

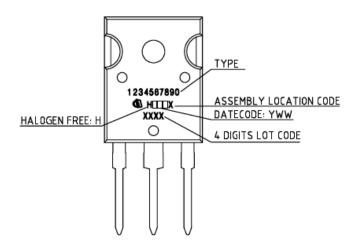
IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

<u>Diodes</u>

- 1.- ANODE/OPEN
- 2.- CATHODE 3.- ANODE

TO-247AC Part Marking Information



TO-247AC package is not recommended for Surface Mount Application.



Qualification Information[†]

Qualification Level	Industrial (per JEDEC JESD47F) ^{††}		
Moisture Sensitivity Level	TO-247 N/A		
RoHS Compliant	Yes		

- † Qualification standards can be found at Infineon web site: https://www.infineon.com/
- †† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Rev.	Comments
2014-11-07	2.1	 Updated E_{AS} (L =1mH) = 1102mJ on page 2 Updated note 9 "Limited by T_{Jmax}, starting T_J = 25°C, L = 1mH, R_G = 50Ω, I_{AS} = 47A, V_{GS} =10V". on page 2
2024-10-03	2.2	 Update datasheet to Infineon format Updated Part marking –page 9 Added disclaimer on last page.



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